

Search Notes

Application/Control No.

10/676,631

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

VARIER ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	229	7/17/2007	HN
	230		
	231		
	234		
	235		
	468		
	395.1		
370	395.4		
370	420		
709	223		
	225		
	226		
	229		
709	232		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
370	468	7/17/2007	HN
	395.2		
	420		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	7/17/2007	HN